

Content	Page No.
Title of Thesis	i
Certificate	ii
Declaration by the Candidate & Certificate by the Supervisor(s)	iii
Copyright Transfer Certificate	iv
Dedication	v
Acknowledgement	vi-viii
Contents	ix-xiv
List of Figures	xv-xxi
List of Tables	xxii-xxiii
List of symbols/ Abbreviation	xxiv-xxvi
Preface	xxvii-xxxiii
CHAPTER – 1	1-61
Introduction	
1.1. History of Perovskite	1
1.2. Structure of Perovskites	2
1.3. Classification of Perovskites	5
1.3.1. $A^{+1}B^{+5}O_3$ Perovskite	6
1.3.2. $A^{+2}B^{+4}O_3$ Perovskite	6
1.3.3. $A^{+3}B^{+3}O_3$ Perovskite	7
1.4. Substitution in Perovskite Materials	7
1.4.1. Isovalent Substitutions	8

1.4.2. Heterovalent substitution	8
1.4.2.1. Acceptor substitution	9
1.4.2.2. Donor substitution	9
1.5. Application of ABO_3 Perovskites	9
1.6. An Introduction of Dielectrics	11
1.7. Dielectric behaviour of Materials	11
1.8. Polarization in the Dielectric Materials	13
1.8.1. Electronic or Atomic Polarization	14
1.8.2. Ionic Polarization	14
1.8.3. Dipolar or Orientation Polarization	15
1.8.4. Space Charge or Interfacial Polarization	15
1.9. Dielectric loss	17
1.10. Impedance	18
1.11. Complex Perovskite	21
1.12. Crystal Structure of $CaCu_3Ti_4O_{12}$ (CCTO)	22
1.13. Intrinsic and Extrinsic Effects in $CaCu_3Ti_4O_{12}$ (CCTO)	24
1.14. Literature Survey on CCTO	27
1.15. Effect of Doping in CCTO	30
1.15.1. Effects on single dopant in CCTO ceramic	30

1.15.2. Effect of co-doping in CCTO	35
1.16. Application of CCTO	36
1.17. Literature survey on $\text{Bi}_{2/3}\text{Cu}_3\text{Ti}_4\text{O}_{12}$ (BCTO)	37
1.18. Objective of Present Investigations	38
1.19. References	41
CHAPTER – 2	62-77
Experimental Procedure	
2.1. Experiment	62
2.2. Material Synthesis	63
2.2.1. Semi Wet Route	63
2.2.2. Calcination Process	65
2.2.3. Sintering Process	65
2.3. Characterization Technique for the Synthesized Ceramic Materials	66
2.3.1. X-Ray Diffraction Analysis	66
2.3.2. Scanning Electron Microscopy (SEM) Analysis	68
2.3.3. Energy Dispersive X-ray Spectroscopy (EDX)	70
2.3.4. Transmission Electron Microscopy (TEM) Analysis	71
2.3.5. Atomic Force Microscopy (AFM) analysis	72
2.3.6. Fourier Transform Infrared Spectroscopy (FT-IR)	72
2.3.7. X-ray Photoelectron Spectroscopy (XPS)	73

2.3.8. Electrical and Dielectric Measurements	73
2.3.9. Impedance Spectroscopy (IS)	75
2.4. References	77
CHAPTER – 3 Effect of Nd-doped $\text{Bi}_{2/3}\text{Cu}_3\text{Ti}_4\text{O}_{12}$ Ceramics on the Microstructure, Dielectric and Electrical Properties	78-106
3.1. Introduction	78
3.2. Experimental	80
3.3. Results and discussion	81
3.3.1. Microstructural studies	81
3.3.2. Dielectric Studies	88
3.4. Conclusion	96
3.5. References	98
CHAPTER – 4 Effect of Sm-doped $\text{Bi}_{2/3}\text{Cu}_3\text{Ti}_4\text{O}_{12}$ Ceramics on the Microstructure, Dielectric and Electrical Properties	107-136
4.1. Introduction	107
4.2. Experimental	109
4.3. Results and discussion	110
4.3.1. Microstructural studies	110
4.3.2. Dielectric Studies	120

4.4. Conclusion	127
4.5. References	129
CHAPTER – 5 Effect of Gd-doped Bi_{2/3}Cu₃Ti₄O₁₂ Ceramics on the Microstructure, Dielectric and Electrical Properties	137-162
5.1. Introduction	137
5.2. Experimental	139
5.3. Results and discussion	141
5.3.1. Microstructural studies	141
5.3.2. Dielectric Studies	149
5.4. Conclusion	154
5.4. References	156
CHAPTER – 6 Effect of Dy-doped Bi_{2/3}Cu₃Ti₄O₁₂ ceramics on the Microstructure, Dielectric, and Electrical properties	163-190
6.1. Introduction	163
6.2. Experimental	165
6.3. Results and discussion	166
6.3.1. Microstructural studies	166
6.3.2. Dielectric Studies	174

6.4. Conclusion	178
6.5. References	180
CHAPTER – 7 Summary and Future Scope	191-193
7.1 Summary	191
7.2 Future Scope	192
List of Publication	194-196